

2SJ668

TOSHIBA Field Effect Transistor Silicon P-Channel MOS Type (U-MOSIII)

2SJ668

Relay Drive, DC/DC Converter and Motor Drive Applications

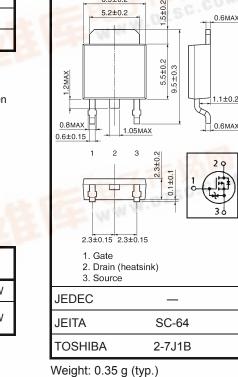
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TOSHIBA

- 4 V gate drive •
- Low drain-source ON-resistance: $RDS(ON) = 0.12 \Omega$ (typ.)
- High forward transfer admittance: $|Y_{fs}| = 5.0 \text{ S}$ (typ.)
- Low leakage current: $I_{DSS} = -100 \ \mu A \ (max) \ (V_{DS} = -60 \ V)$
- Enhancement mode: $V_{th} = -0.8$ to -2.0 V ($V_{DS} = -10$ V, $I_{D} = -1$ mA)

Charact	eristic	Symbol	Rating	Unit	
Drain-source voltage		V _{DSS}	-60	V	
Drain-gate voltage (R _{GS} = 20 kΩ)		V _{DGR}	-60	V	
Gate-source voltag	e	V _{GSS}	±20	V	
Drain current	DC (Note 1)	ID	-5	А	
	Pulse(Note 1)	IDP	-20	А	
Drain power dissipation		PD	20	W	
Single pulse avalanche energy (Note 2)		E _{AS}	40.5	mJ	
Avalanche current		I _{AR}	-5	А	
Repetitive avalanche energy (Note 3)		E _{AR}	2	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	

Absolute Maximum Ratings (Ta = 25°C)



 5.2 ± 0.2

0.6MA

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Thermal Characteristics

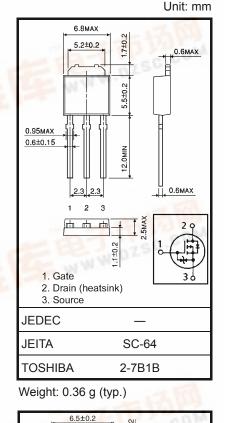
Characteristic	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch−c)}	6.25	°C / W
Thermal resistance, channel to ambient	R _{th (ch−a)}	125	°C / W

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: $V_{DD} = -25 \text{ V}$, $T_{ch} = 25^{\circ}\text{C}$ (initial), L = 2.2 mH, $R_G = 25 \Omega$, $I_{AR} = -5 A$

Note 3: __Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device. Handle with care.



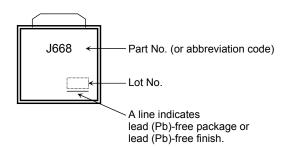
Electrical Characteristics (Ta = 25°C)

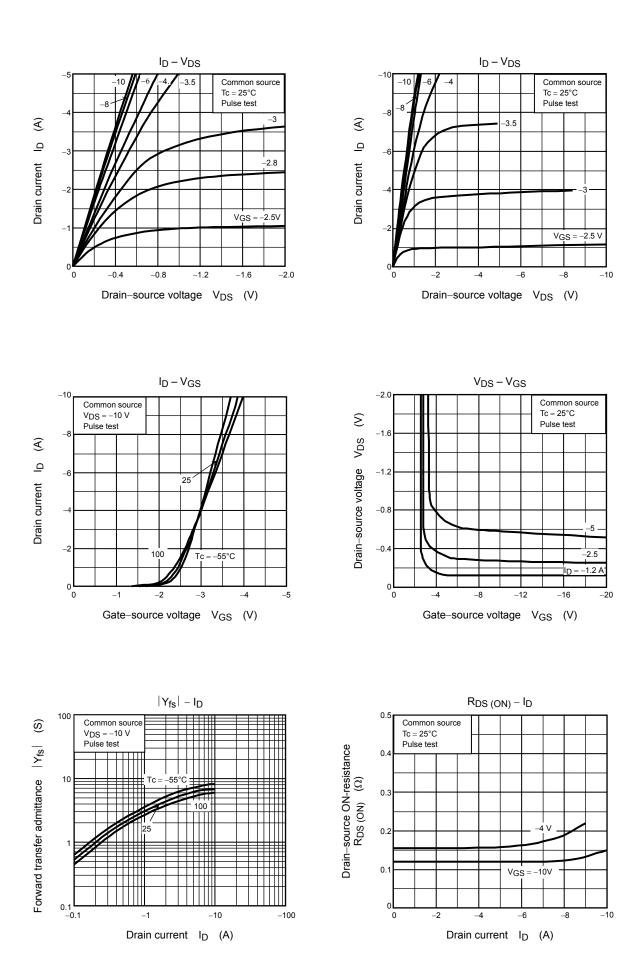
Chara	cteristic	Symbol	Test Condition	Min	Тур.	Мах	Unit
Gate leakage cu	ırrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V		—	±10	μA
Drain cutoff curr	ent	IDSS	V_{DS} = -60 V, V_{GS} = 0 V	_	_	-100	μA
Drain-source breakdown voltage		V (BR) DSS	I _D = -10 mA, V _{GS} = 0 V	-60	_	_	V
		V (BR) DSX	I _D = -10 mA, V _{GS} = 20 V	-35	_	_	V
Gate threshold	voltage	V _{th}	$V_{DS} = -10 \text{ V}, \text{ I}_{D} = -1 \text{ mA}$	-0.8	_	-2.0	V
Drain-source ON-resistance			V _{GS} = -4 V, I _D = -2.5 A		0.16	0.25	Ω
		R _{DS} (ON)	V _{GS} = -10 V, I _D = -2.5 A		0.12	0.17	
Forward transfe	r admittance	Y _{fs}	V _{DS} = -10 V, I _D = -2.5 A	2.5	5.0	_	S
Input capacitance		C _{iss}		_	700	_	pF
Reverse transfer capacitance		C _{rss}	V _{DS} = −10 V, V _{GS} = 0 V, f = 1 MHz	_	60	_	
Output capacitance		C _{oss}		_	90	_	
Switching time	Rise time	tr	V_{GS} $-10 V$ C_{GS} $R_{L} =$	_	14	_	
	Turn-on time	t _{on}		_	24	_	ns
	Fall time	t _f		_	14	_	
	Turn-off time	t _{off}	Duty \leq 1%, t _w = 10 μ s		95	_	
Total gate charge (gate-source plus gate-drain)		Qg		_	15	_	nC
Gate-source charge		Q _{gs}	V _{DD} ≈ −48 V, V _{GS} = −10 V, I _D = −5 A		11	_	
Gate-drain ("Miller") charge		Q _{gd}]		4	_	

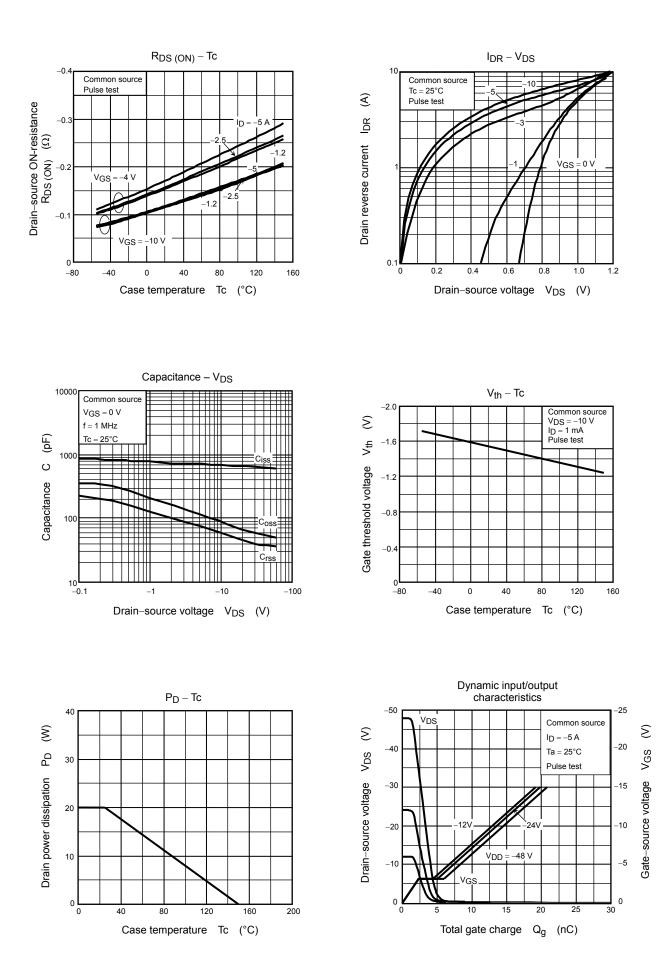
Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteristic	Symbol	Test Condition	Min	Тур.	Мах	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	_	_	-5	А
Pulse drain reverse current (Note 1)	I _{DRP}	_	_	_	-20	А
Forward voltage (diode)	V _{DSF}	I _{DR} = -5 A, V _{GS} = 0 V	_	_	1.7	V
Reverse recovery time	t _{rr}	I _{DR} = -5 A, V _{GS} = 0 V		40	_	ns
Reverse recovery charge	Qrr	dl _{DR} / dt = 50 A / μS		32	_	nC

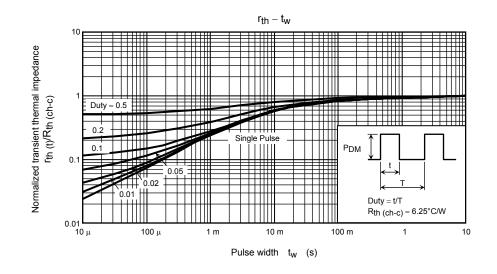
Marking

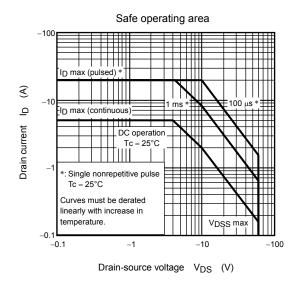


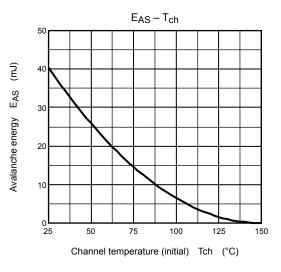


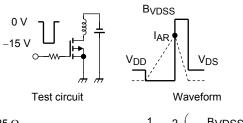


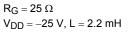
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 $E_{AS} = \frac{1}{2} \cdot L \cdot I^2 \cdot \left(\frac{B_{VDSS}}{B_{VDSS} - V_{DD}} \right)$

RESTRICTIONS ON PRODUCT USE

Handbook" etc.

20070701-EN

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